CCIC-SET

Electronic Testing Building, Shahe Road, Xili, Nanshan District, Shenzhen, 518055, P. R. China

TEL:86 755 26627338 Fax: 86 755 26627238

Test Lab Attestation Letter

Date of Test:

2015-07-15~2015-07-20

Applicant Name:

Queclink Wireless Solutions Co., Ltd.

FCC ID:

YQD-GL300W

Name of Engineer Performing Test:

MeiChun

Statement of Compliance:

(Test Lab) declares that this Unit has been tested in accordance with the test method identified in this test report and that we observed it being tested. It also declares that the Unit complies with the relevant limits. All instrumentation and accessories used to test this unit for compliance to the indicated test method are calibrated regularly in accordance with ISO 17025:2005 requirements by laboratories accredited by A2LA, NVLAP, or ACLAS for the measurement parameters.

The measurements were made at:

(Test Lab Name) CCIC Southern Electronic Product Testing

(Shenzhen) Co., Ltd.

(Address) Electronic Testing Building, Shahe Road, Xili, Nanshan District, Shenzhen, 518055, P. R. China

Test Lab Witness-

Signature of Test Lab Witness:

Shuangwen Zhang

Full Name, Typed:

Senior Engineer

Title of Witness:

zhangsw@set.org.cn

Email Address:

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Company Sta

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